

Application/Control No. 10/672,521	Applicant(s)/Patent under Reexamination TAKAYAMA ET AL.
Examiner	Art Unit
Cheuna Lee	2812

		ORIGINAL			INTERNATIONAL CLASSIFICATION											
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	MUNCO struments E			SUPERVISORY PATENT EX JMINER (Primary Examiner) (Date)						Print Claim(s) Print						

	laims	aims renumbered in the same order as presented by applicant										☐ CPA			☐ T.D.		☐ R.1.47		
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
	1		6	31			61	1		91			121			151			181
	2		7	32			62			92			122			152			182
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	4		8	34			64]		94			124	!		154			184
	5		9	35			65			95			125			155			185
	6		11	36			66			96			126			156			186
	7		12	37			67			97			127			157			187
	8			38			68			98			128			158			188
	9		13	39			69			99			129			159			189
	10		14	40			70			100			130			160			190
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	16		5	46			76			106			136			166			196
	17		10	47	1		77			107			137			167			197
	18		15	48	1		78			108			138			168			198
	19		20	49			79			109			139			169			199
	20			50	1		80]		110			140			170			200
	21			51	1		81			111			141.			171			201
	22			52	1		82]		112			142			172			202
	23			53	1		83]		113			143			173			203
	24			54	1		84	1		114			144			174			204
	25			55]		85			115			145			175			205
1	26			56]		86]		116			146			176			206
2	27			57	1		87			117			147			177			207
	28			58	1		88			118			148			178			208
3	29)		59	1		89			119]		149			179			209
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